## **Amendments to the Specification**

Please replace the paragraphs at page 6, line 24 – page 7, line 9 with the following amended paragraph:

- Fig. 1 is a system block diagram showing the outline of the embodiment of the present invention;
  - Fig. 2 is a diagram explaining the classification, classification;
  - Fig. 3 shows the composition of the display screen; screen;
  - Fig. 4 is the detailed view of a part of the screen in Fig. 3. Fig. 3;
  - Fig. 5 is the detailed view of a part of the screen in Fig. 3, Fig. 3;
  - Fig. 6 is the detailed view of another part of the screen in Fig. 3, Fig. 3; and
  - Fig. 7 is the detailed view of another part of the screen in Fig. 3. Fig. 3:
  - Fig. 8 shows the detail of the screen composition, composition;
  - Fig. 9 shows the detail of another screen composition, composition;
  - Fig. 10 shows the detail of another screen composition, and composition;
  - Fig. 11 shows the selfcheck screen; and
  - Fig. 12 is a flowchart.

Please replace the paragraph at page 13, lines 7-12 with the following amended paragraph:

Figs. 8, 9 and 19 shows an example of the display for the classification. Fig. 8 shows a sub class and user class setting screen. In the sub class tree display area

40, the semiconductor wafer # (No.) and 13 sub-classes classes are displayed, and each class is as shown by the sub-class class display buttons 50.

Please replace the paragraph at page 14, lines 6-14 with the following amended paragraph:

In the main class thumbnail display area 42, 9 columns by 9 rows in the total of 81 of the thumbnail images 51 (48 pixels) of the inspection images are displayed at a time. The user class display area 43 is used for an operation to add a user class. In this area, the selected sub class 81 is displayed by operating the sub class class display button 50 and an optional user class 82 is set. The set user class is displayed beneath each sub class column.